Issue Classification

Application/Control No.	Applicant(s)/Patent Under Reexamination
10760664	VAN OSTRAND ET AL.
Examiner	**Art Unit**
Chen-Wen Jiang	3744

ORIGINAL

CLASS	SUBCLASS
236	1B

CROSS REFERENCE(S)

CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
236	1R				
62	228.5				

INTERNATIONAL CLASSIFICATION

CLAIMED	NON-CLAIMED
G 0 5 D 23 / 00 (2006.01.01)	
F 2 3 N 1 / 00 (2006.01.01)	

NONE		Total Claims Allowed:
(Assistant Examiner) (Date)		17
/Chen-Wen Jiang/	2/1/2008	O.G. Print Claim(s): 1 / O.G. Print Figure: 1
(Primary Examiner)	(Date)	